



**PATENT**

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

IN RE APPLICATION OF: WHONCHEE LEE ET AL.

APPLICATION No.: 09/887,767

FILED: JUNE 21, 2001

FOR: **MICROELECTRONIC SUBSTRATE  
HAVING CONDUCTIVE MATERIAL WITH  
BLUNT CORNERED APERTURES, AND  
ASSOCIATED METHODS FOR  
REMOVING CONDUCTIVE MATERIAL**

EXAMINER: ALVIN J. GRANT

ART UNIT: 3723

CONF. NO: 9072

**Comments on Statement of Reasons for Allowance**

Mail Stop Issue Fee  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

In the Notice of Allowability mailed February 22, 2006, the Examiner allowed claims 1-8, 20-35 and 37-51. Although the applicants' attorney agrees with the Examiner's conclusion that these claims are allowable, the applicants' attorney notes that the claims may be allowable for reasons other than those identified by the Examiner and does not concede that the Examiner's characterizations of the terms of the claims and the prior art are correct.

Respectfully submitted,  
Perkins Coie LLP

Chen Liang  
Registration No. 51,945

Date: May 22, 2006

**Correspondence Address:**

Customer No. 25096  
Perkins Coie LLP  
P.O. Box 1247  
Seattle, Washington 98111-1247  
(206) 359-8000